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	APPLICANT	MAMITSU et al.		
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REFERENCE DESIGNATION

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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
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TRANSLATION

	DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
								Eng. Abstract	
<i>BA</i>	2000-31355	01/2000	JAPAN					X	
<i>BA</i>	10-65072	03/1998	JAPAN					X	
<i>BA</i>	11-284103	10/1999	JAPAN					X	

- Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	<i>[Signature]</i>	DATE CONSIDERED	<i>3/17/05</i>
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